# TABLE OF CONTENTS

Features
Applications1
General Description 1
Functional Block Diagram1
Revision History
Specifications
Timing Diagram 5
Absolute Maximum Ratings
Maximum Power Dissipation 6
ESD Caution
Pin Configuration and Function Descriptions7
Typical Performance Characteristics
Theory of Operation
Gain Selection

## **REVISION HISTORY**

#### 10/12—Rev. A to Rev. B

Changed Digital Input Voltage Low Maximum Parameter from
1.2 V to 2.1 V and Changed Digital Input Voltage High Typical
Parameter from 1.5 V to 2.8 V 4
Updated Outline Dimensions

8/08—Rev. 0 to Rev. A	
Changes to Ordering Guide	. 23

#### 7/08—Revision 0: Initial Version

	Power Supply Regulation and Bypassing	18
	Input Bias Current Return Path	18
	Input Protection	18
	Reference Terminal	19
	Common-Mode Input Voltage Range	19
	Layout	19
	RF Interference	19
	Driving an Analog-to-Digital Converter	20
A	pplications Information	21
	Differential Output	21
	Setting Gains with a Microcontroller	21
	Data Acquisition	22
С	Outline Dimensions	23
	Ordering Guide	23

## **SPECIFICATIONS**

+Vs = +15 V, -Vs = -15 V, V\_{REF} = 0 V @ T\_A = 25°C, G = 1, R\_L = 2 k\Omega, unless otherwise noted.

#### Table 2.

Parameter	Conditions	Min	Тур	Max	Unit
COMMON-MODE REJECTION RATIO (CMRR)					
CMRR to 60 Hz with 1 k $\Omega$ Source Imbalance	+IN = -IN = -10 V to +10 V				
G = 1		80	100		dB
G = 10		96	120		dB
G = 100		100	120		dB
G = 1000		100	120		dB
CMRR to 20 kHz <sup>1</sup>	+IN = -IN = -10 V to +10 V				
G = 1		80			dB
G = 10		96			dB
G = 100		100			dB
G = 1000		100			dB
NOISE					
Voltage Noise, 1 kHz, RTI					
G = 1				45	nV/√Hz
G = 10				12	nV/√Hz
G = 100				11	nV/√Hz
G = 1000				10	nV/√Hz
0.1 Hz to 10 Hz, RTI					
G = 1				2.5	μV p-p
G = 10				1	μV p-p
G = 100				0.5	μV p-p
G = 1000				0.5	μV p-p
Current Noise, 1 kHz			5		pA/√Hz
Current Noise, 0.1 Hz to 10 Hz			60		рАр-р
VOLTAGE OFFSET					
Offset RTI Vos	G = 1, 10, 100, 1000			±150 + 900/G	μV
Over Temperature	$T = -40^{\circ}C \text{ to } +85^{\circ}C$			±210 + 900/G	μV
AverageTC	$T = -40^{\circ}C \text{ to } +85^{\circ}C$			±1.2 + 5/G	µV/°C
Offset Referred to the Input vs. Supply (PSR)	$V_s = \pm 5 V \text{ to } \pm 15 V$			±5 + 25/G	μV/V
INPUT CURRENT					
Input Bias Current			5	50	nA
Over Temperature <sup>2</sup>	$T = -40^{\circ}C \text{ to } +85^{\circ}C$	40		60	nA
Average TC	$T = -40^{\circ}C \text{ to } +85^{\circ}C$			400	pA/°C
Input Offset Current			5	40	nA
Over Temperature	$T = -40^{\circ}C \text{ to } +85^{\circ}C$			40	nA
Average TC	$T = -40^{\circ}C \text{ to } +85^{\circ}C$			160	pA/°C
DYNAMIC RESPONSE					
Small-Signal –3 dB Bandwidth					
G = 1		10			MHz
G = 10		4			MHz
G = 100		550			kHz
G = 1000		60			kHz
Settling Time 0.01%	$\Delta OUT = 10 V step$				
G = 1				700	ns
G = 10				680	ns
G = 100				1.5	μs
G = 1000		1		14	μs

Parameter	Conditions	Min	Тур	Max	Unit
Settling Time 0.001%	$\Delta OUT = 10 V step$				
G = 1				780	ns
G = 10				880	ns
G =100				1.8	μs
G = 1000				1.8	μs
Slew Rate					
G = 1		20			V/µs
G = 10		20			V/µs
G = 100		12			V/µs
G = 1000		2			V/µs
Total Harmonic Distortion + Noise	$f = 1 \text{ kHz}$ , $R_L = 10 \text{ k}\Omega$ , ±10 V, G = 1, 10 Hz to 22 kHz bandpass filter		-110		dB
GAIN					
Gain Range	G = 1, 10, 100, 1000	1		1000	V/V
Gain Error	$OUT = \pm 10 V$				
G = 1				0.03	%
G = 10, 100, 1000				0.04	%
Gain Nonlinearity	OUT = -10 V to +10 V				
G = 1	$R_L = 10 \text{ k}\Omega$ , 2 k $\Omega$ , 600 $\Omega$			5	ppm
G = 10	$R_L = 10 \text{ k}\Omega$ , 2 $\text{k}\Omega$ , 600 $\Omega$			3	ppm
G = 100	$R_L = 10 \text{ k}\Omega, 2 \text{ k}\Omega, 600 \Omega$			18	ppm
G = 1000	$R_L = 10 \text{ k}\Omega, 2 \text{ k}\Omega, 600 \Omega$			110	ppm
Gain vs. Temperature	All gains		3	10	ppm/°0
NPUT					
Input Impedance					
Differential			4  1.25		GΩ∥pF
Common Mode			1  5		GΩ∥pF
Input Operating Voltage Range	$V_s = \pm 5 V \text{ to } \pm 15 V$	-Vs + 1		+Vs - 1.5	V
Over Temperature <sup>3</sup>	$T = -40^{\circ}C$ to $+85^{\circ}C$	$-V_{s} + 1.2$		+V <sub>s</sub> - 1.7	V
OUTPUT					
Output Swing		-13.7		+13.6	V
Over Temperature <sup>4</sup>	$T = -40^{\circ}C$ to $+85^{\circ}C$	-13.7		+13.6	V
Short-Circuit Current			37		mA
REFERENCE INPUT					
R <sub>IN</sub>			20		kΩ
l <sub>in</sub>	+IN, -IN, REF = 0			1	μA
Voltage Range		-Vs		+Vs	V
Gain to Output			$1 \pm 0.0001$		V/V
DIGITAL LOGIC					
Digital Ground Voltage, DGND	Referred to GND	$-V_{s} + 4.25$	0	+Vs - 2.7	V
Digital Input Voltage Low Referred to GND		DGND		2.1	V
Digital Input Voltage High				+Vs	V
Digital Input Current			1		μA
Gain Switching Time⁵				325	ns
tsu	See Figure 3 timing diagram	15			ns
t <sub>HD</sub>		30			ns
t wr-low		20			ns
t wr-high		15			ns

Parameter	Conditions	Min	Тур	Max	Unit
POWER SUPPLY					
Operating Range		±5		±15	V
Quiescent Current, +Is			4.6	5.3	mA
Quiescent Current, –Is			4.5	5.3	mA
Over Temperature	$T = -40^{\circ}C \text{ to } +85^{\circ}C$			6	mA
TEMPERATURE RANGE					
Specified Performance		-40		+85	°C

<sup>1</sup> See Figure 20 for CMRR vs. frequency for more information on typical performance over frequency. <sup>2</sup> Input bias current over temperature: minimum at hot and maximum at cold.

<sup>3</sup> See Figure 30 for input voltage limit vs. supply voltage and temperature.
 <sup>4</sup> See Figure 32, Figure 33, and Figure 34 for output voltage swing vs. supply voltage and temperature for various loads.

<sup>5</sup> Add time for the output to slew and settle to calculate the total time for a gain change.

#### **TIMING DIAGRAM**

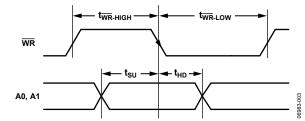


Figure 3. Timing Diagram for Latched Gain Mode (See the Timing for Latched Gain Mode Section)

## **ABSOLUTE MAXIMUM RATINGS**

#### Table 3.

Parameter	Rating
Supply Voltage	±17 V
Power Dissipation	See Figure 4
Output Short-Circuit Current	Indefinite <sup>1</sup>
Common-Mode Input Voltage	±Vs
Differential Input Voltage	±Vs
Digital Logic Inputs	±Vs
Storage Temperature Range	–65°C to +125°C
Operating Temperature Range <sup>2</sup>	–40°C to +85°C
Lead Temperature (Soldering 10 sec)	300°C
Junction Temperature	140°C
$\theta_{JA}$ (4-Layer JEDEC Standard Board)	112°C/W
Package Glass Transition Temperature	140°C

<sup>1</sup> Assumes the load is referenced to midsupply.

 $^2$  Temperature for specified performance is  $-40^\circ$ C to  $+85^\circ$ C. For performance to  $+125^\circ$ C, see the Typical Performance Characteristics section.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### MAXIMUM POWER DISSIPATION

The maximum safe power dissipation in the AD8253 package is limited by the associated rise in junction temperature ( $T_J$ ) on the die. The plastic encapsulating the die locally reaches the junction temperature. At approximately 140°C, which is the glass transition temperature, the plastic changes its properties. Even temporarily exceeding this temperature limit can change the stresses that the package exerts on the die, permanently shifting the parametric performance of the AD8253. Exceeding a junction temperature of 140°C for an extended period can result in changes in silicon devices, potentially causing failure.

The still-air thermal properties of the package and PCB ( $\theta_{JA}$ ), the ambient temperature ( $T_A$ ), and the total power dissipated in the package ( $P_D$ ) determine the junction temperature of the die. The junction temperature is calculated as

$$T_J = T_A + \left( P_D \times \theta_{JA} \right)$$

The power dissipated in the package  $(P_D)$  is the sum of the quiescent power dissipation and the power dissipated in the package due to the load drive for all outputs. The quiescent

power is the voltage between the supply pins (V<sub>s</sub>) times the quiescent current (I<sub>s</sub>). Assuming the load (R<sub>L</sub>) is referenced to midsupply, the total drive power is  $V_s/2 \times I_{OUT}$ , some of which is dissipated in the package and some of which is dissipated in the load ( $V_{OUT} \times I_{OUT}$ ).

The difference between the total drive power and the load power is the drive power dissipated in the package.

 $P_D$  = Quiescent Power + (Total Drive Power – Load Power)

$$P_D = \left(V_S \times I_S\right) + \left(\frac{V_S}{2} \times \frac{V_{OUT}}{R_L}\right) - \frac{V_{OUT}^2}{R_L}$$

In single-supply operation with  $R_{\rm L}$  referenced to  $-V_S$  , the worst case is  $V_{\rm OUT}$  =  $V_S/2.$ 

Airflow increases heat dissipation, effectively reducing  $\theta_{JA}$ . In addition, more metal directly in contact with the package leads from metal traces through holes, ground, and power planes reduces the  $\theta_{JA}$ .

Figure 4 shows the maximum safe power dissipation in the package vs. the ambient temperature on a 4-layer JEDEC standard board.

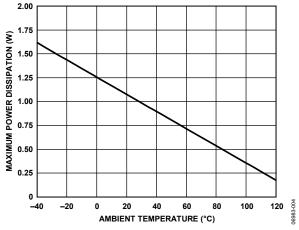


Figure 4. Maximum Power Dissipation vs. Ambient Temperature

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

# PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

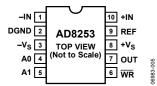


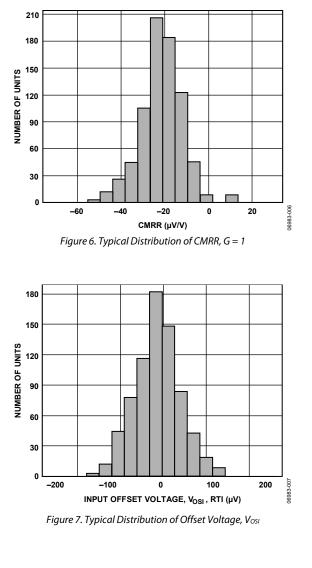
Figure 5. 10-Lead MSOP (RM-10) Pin Configuration

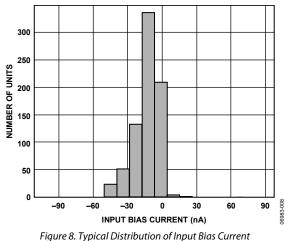
	Table 4.1 In Function Descriptions					
Pin No.	Mnemonic	Description				
1	–IN	Inverting Input Terminal. True differential input.				
2	DGND	Digital Ground.				
3	–Vs	Negative Supply Terminal.				
4	AO	Gain Setting Pin (LSB).				
5	A1	Gain Setting Pin (MSB).				
6	WR	Write Enable.				
7	OUT	Output Terminal.				
8	+Vs	Positive Supply Terminal.				
9	REF	Reference Voltage Terminal.				
10	+IN	Noninverting Input Terminal. True differential input.				

#### **Table 4. Pin Function Descriptions**

## **TYPICAL PERFORMANCE CHARACTERISTICS**

 $T_{\rm A}$  @ 25°C, +V\_S = +15 V, -V\_S = -15 V,  $R_{\rm L}$  = 10 k $\Omega,$  unless otherwise noted.





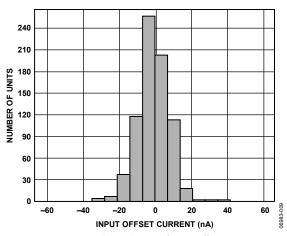
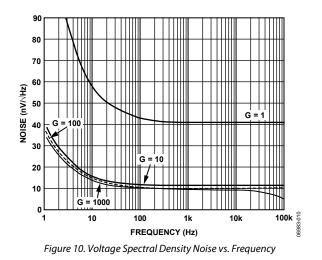


Figure 9. Typical Distribution of Input Offset Current



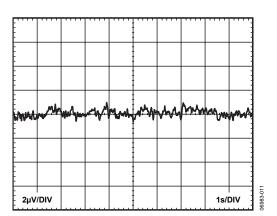


Figure 11.0.1 Hz to 10 Hz RTI Voltage Noise, G = 1

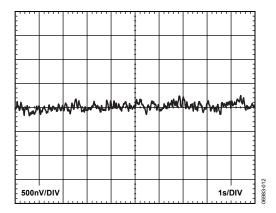


Figure 12. 0.1 Hz to 10 Hz RTI Voltage Noise, G = 1000

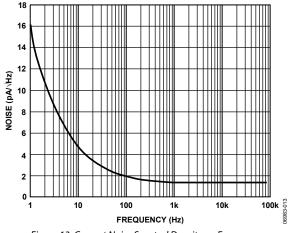


Figure 13. Current Noise Spectral Density vs. Frequency

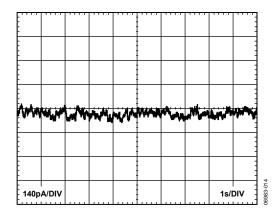
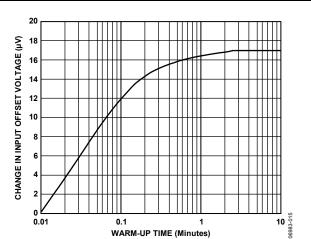
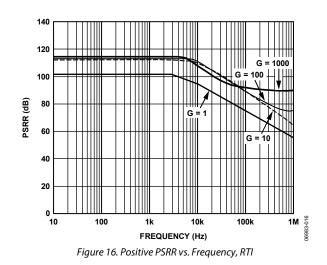


Figure 14.0.1 Hz to 10 Hz Current Noise



 WARM-UP TIME (Minutes)
 #

 Figure 15. Change in Input Offset Voltage vs. Warm-Up Time, G = 1000



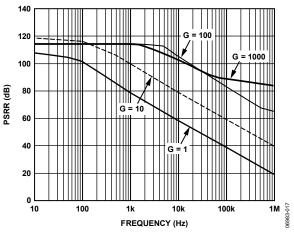


Figure 17. Negative PSRR vs. Frequency, RTI

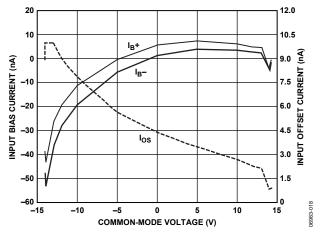


Figure 18. Input Bias Current and Offset Current vs. Common-Mode Voltage

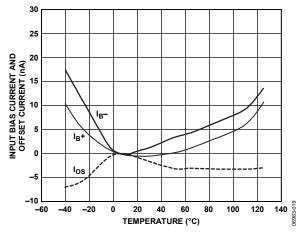
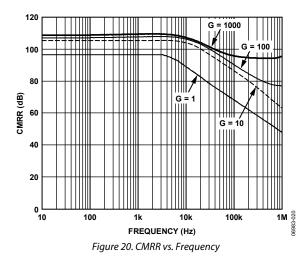
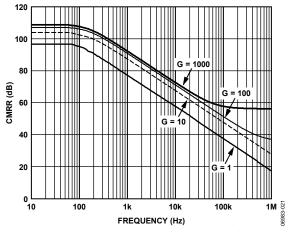
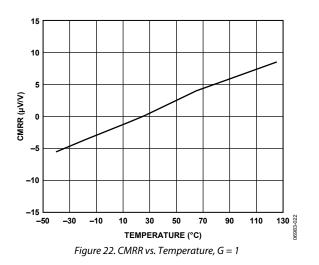


Figure 19. Input Bias Current and Offset Current vs. Temperature









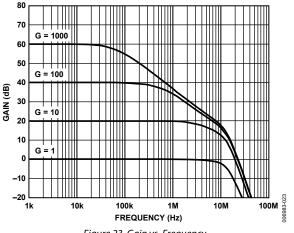


Figure 23. Gain vs. Frequency

40 30 NONLINEARITY (10ppm/DIV) 20 10 0 -10 -20 -30 –40 ∟ –10 6983-024 -8 -6 -2 0 10 -4 2 4 6 8 OUTPUT VOLTAGE (V)

Figure 24. Gain Nonlinearity, G = 1,  $R_L = 10 \text{ k}\Omega$ ,  $2 \text{ k}\Omega$ ,  $600 \Omega$ 

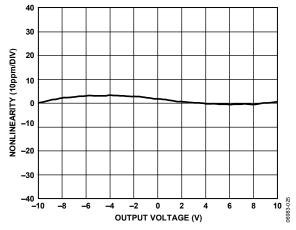


Figure 25. Gain Nonlinearity, G = 10,  $R_L = 10 k\Omega$ ,  $2 k\Omega$ ,  $600 \Omega$ 

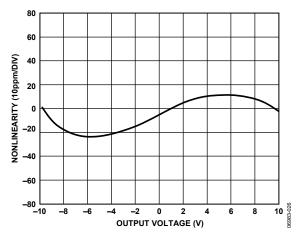
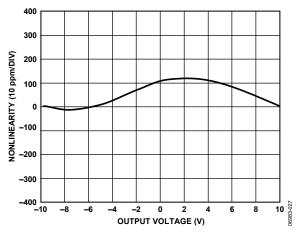
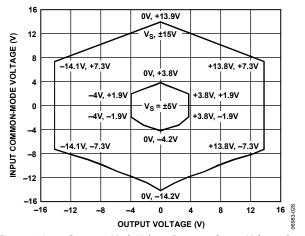


Figure 26. Gain Nonlinearity, G = 100,  $R_L$  = 10 k $\Omega$ , 2 k $\Omega$ , 600  $\Omega$ 

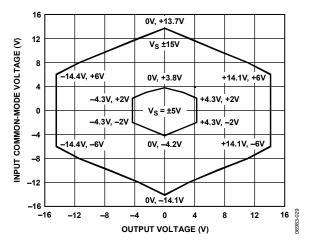


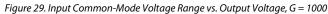
AD8253

Figure 27. Gain Nonlinearity, G = 1000,  $R_L = 10 k\Omega$ ,  $2 k\Omega$ ,  $600 \Omega$ 









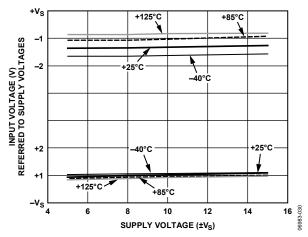


Figure 30. Input Voltage Limit vs. Supply Voltage, G = 1,  $V_{REF} = 0 V$ ,  $R_L = 10 k\Omega$ 

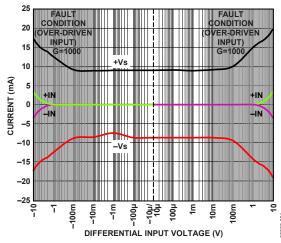


Figure 31. Fault Current Draw vs. Input Voltage, G = 1000,  $R_L = 10 k\Omega$ 

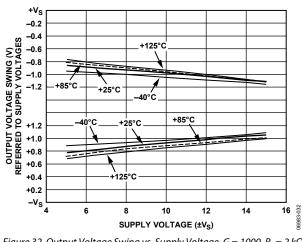


Figure 32. Output Voltage Swing vs. Supply Voltage, G = 1000,  $R_L = 2 k\Omega$ 

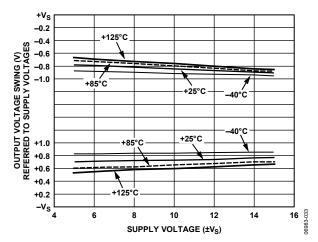


Figure 33. Output Voltage Swing vs. Supply Voltage, G = 1000,  $R_L = 10 k\Omega$ 

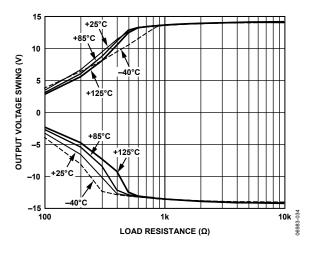


Figure 34. Output Voltage Swing vs. Load Resistance

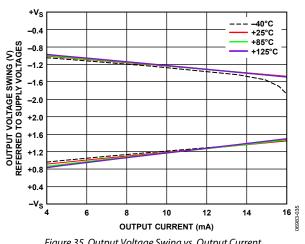


Figure 35. Output Voltage Swing vs. Output Current

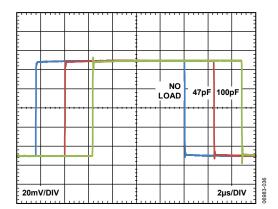


Figure 36. Small-Signal Pulse Response for Various Capacitive Loads, G = 1

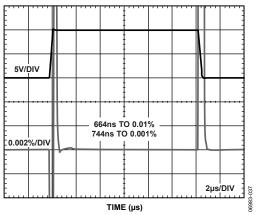


Figure 37. Large-Signal Pulse Response and Settling Time, G = 1,  $R_L$  = 10 k $\Omega$ 

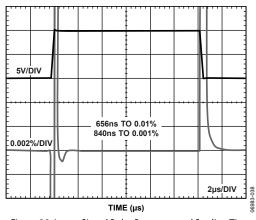


Figure 38. Large-Signal Pulse Response and Settling Time,  $G = 10, R_L = 10 \ k\Omega$ 

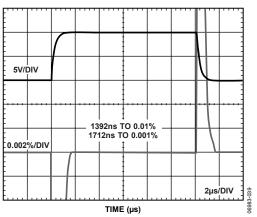


Figure 39. Large-Signal Pulse Response and Settling Time,  $G = 100, R_L = 10 k\Omega$ 

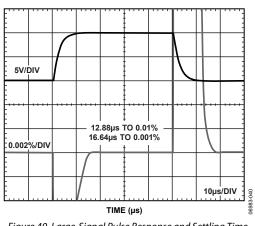


Figure 40. Large-Signal Pulse Response and Settling Time,  $G = 1000, R_L = 10 \, k\Omega$ 

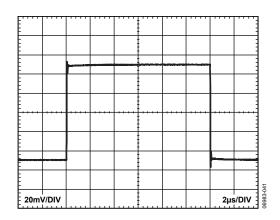


Figure 41. Small-Signal Response,  $G = 1, R_L = 2 k\Omega, C_L = 100$ 

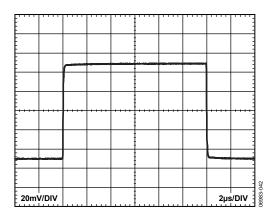


Figure 42. Small-Signal Response, G = 10,  $R_L = 2 k\Omega$ ,  $C_L = 100 pF$ 

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Figure 43. Small-Signal Response, G = 100,  $R_L$  = 2 k $\Omega$ ,  $C_L$  = 100 pF

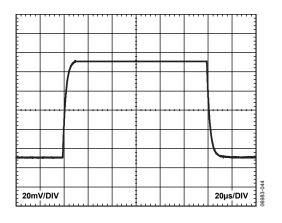
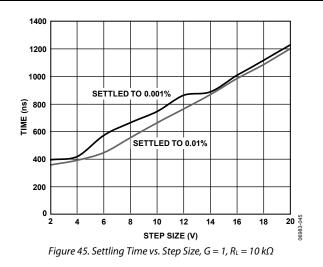
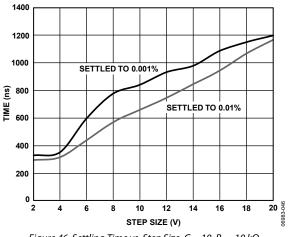
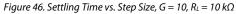
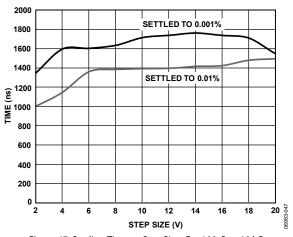


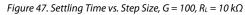
Figure 44. Small-Signal Response, G = 1000,  $R_L = 2 k\Omega$ ,  $C_L = 100 pF$ 

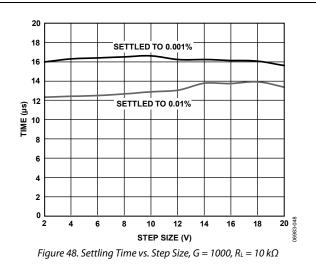


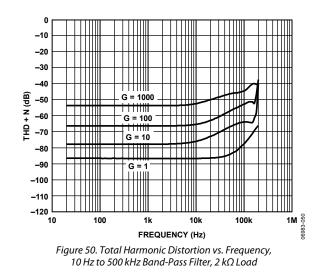


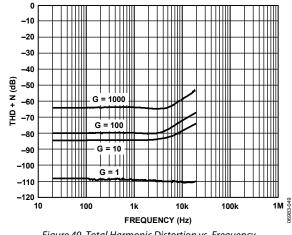


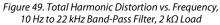




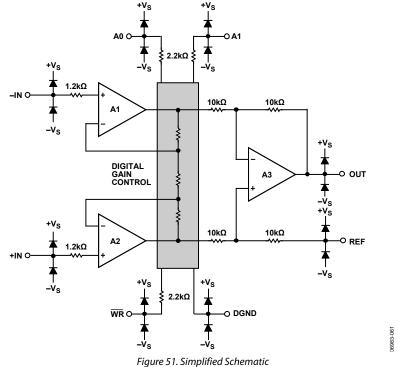








## THEORY OF OPERATION



The AD8253 is a monolithic instrumentation amplifier based on the classic 3-op-amp topology, as shown in Figure 51. It is fabricated on the Analog Devices, Inc., proprietary *i*CMOS<sup>\*</sup> process that provides precision linear performance and a robust digital interface. A parallel interface allows users to digitally program gains of 1, 10, 100, and 1000. Gain control is achieved by switching resistors in an internal precision resistor array (as shown in Figure 51).

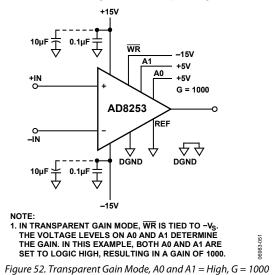
All internal amplifiers employ distortion cancellation circuitry and achieve high linearity and ultralow THD. Laser-trimmed resistors allow for a maximum gain error of less than 0.03% for G = 1 and a minimum CMRR of 100 dB for G = 1000. A pinout optimized for high CMRR over frequency enables the AD8253 to offer a guaranteed minimum CMRR over frequency of 80 dB at 20 kHz (G = 1). The balanced input reduces the parasitics that in the past had adversely affected CMRR performance.

#### GAIN SELECTION

This section describes how to configure the AD8253 for basic operation. Logic low and logic high voltage limits are listed in the Specifications section. Typically, logic low is 0 V and logic high is 5 V; both voltages are measured with respect to DGND. Refer to the specifications table (Table 2) for the permissible voltage range of DGND. The gain of the AD8253 can be set using two methods: transparent gain mode and latched gain mode. Regardless of the mode, pull-up or pull-down resistors should be used to provide a well-defined voltage at the A0 and A1 pins.

#### Transparent Gain Mode

The easiest way to set the gain is to program it directly via a logic high or logic low voltage applied to A0 and A1. Figure 52 shows an example of this gain setting method, referred to throughout the data sheet as transparent gain mode. Tie  $\overline{WR}$  to the negative supply to engage transparent gain mode. In this mode, any change in voltage applied to A0 and A1 from logic low to logic high, or vice versa, immediately results in a gain change. Table 5 is the truth table for transparent gain mode, and Figure 52 shows the AD8253 configured in transparent gain mode.

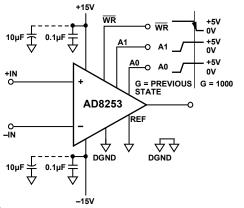


	8							
WR	A1	A0	Gain					
$-V_{S}$	Low	Low	1					
$-V_{\text{S}}$	Low	High	10					
$-V_{s}$	High	Low	100					
–Vs	High	Hiah	1000					

Table 5. Truth Table Logic Levels for Transparent Gain Mode

#### Latched Gain Mode

Some applications have multiple programmable devices such as multiplexers or other programmable gain instrumentation amplifiers on the same PCB. In such cases, devices can share a data bus. The gain of the AD8253 can be set using  $\overline{WR}$  as a latch, allowing other devices to share A0 and A1. Figure 53 shows a schematic using this method, known as latched gain mode. The AD8253 is in this mode when  $\overline{WR}$  is held at logic high or logic low, typically 5 V and 0 V, respectively. The voltages on A0 and A1 are read on the downward edge of the  $\overline{WR}$  signal as it transitions from logic high to logic low. This latches in the logic levels on A0 and A1, resulting in a gain change. See the truth table listing in Table 6 for more on these gain changes.



NOTE: 1. ON THE DOWNWARD EDGE OF WR, AS IT TRANSITIONS FROM LOGIC HIGH TO LOGIC LOW, THE VOLTAGES ON A0 AND A1 ARE READ AND LATCHED IN, RESULTING IN A GAIN CHANGE. IN THIS EXAMPLE, THE GAIN SWITCHES TO G = 1000.

Figure 53. Latched Gain Mode, G = 1000

WR	A1	A0	Gain					
High to Low	Low	Low	Change to 1					
High to Low	Low	High	Change to 10					
High to Low	High	Low	Change to 100					
High to Low	High	High	Change to 1000					
Low to Low	<b>X</b> <sup>1</sup>	<b>X</b> <sup>1</sup>	No change					
Low to High	<b>X</b> <sup>1</sup>	<b>X</b> <sup>1</sup>	No change					
High to High	<b>X</b> <sup>1</sup>	<b>X</b> <sup>1</sup>	No change					

Table 6. Truth Table Logic Levels for Latched Gain Mode

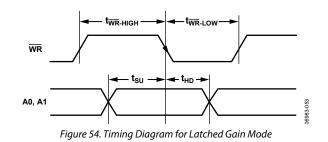
<sup>1</sup> X = don't care.

On power-up, the AD8253 defaults to a gain of 1 when in latched gain mode. In contrast, if the AD8253 is configured in transparent gain mode, it starts at the gain indicated by the voltage levels on A0 and A1 on power-up.

#### Timing for Latched Gain Mode

In latched gain mode, logic levels at A0 and A1 must be held for a minimum setup time, t<sub>SU</sub>, before the downward edge of  $\overline{WR}$ latches in the gain. Similarly, they must be held for a minimum hold time, t<sub>HD</sub>, after the downward edge of  $\overline{WR}$  to ensure that the gain is latched in correctly. After t<sub>HD</sub>, A0 and A1 may change logic levels, but the gain does not change until the next downward edge of  $\overline{WR}$ . The minimum duration that  $\overline{WR}$  can be held high is t  $\overline{WR}$ -HIGH, and t  $\overline{WR}$ -LOW is the minimum duration that  $\overline{WR}$  can be held low. Digital timing specifications are listed in Table 2. The time required for a gain change is dominated by the settling time of the amplifier. A timing diagram is shown in Figure 54.

When sharing a data bus with other devices, logic levels applied to those devices can potentially feed through to the output of the AD8253. Feedthrough can be minimized by decreasing the edge rate of the logic signals. Furthermore, careful layout of the PCB also reduces coupling between the digital and analog portions of the board.



## POWER SUPPLY REGULATION AND BYPASSING

The AD8253 has high PSRR. However, for optimal performance, a stable dc voltage should be used to power the instrumentation amplifier. Noise on the supply pins can adversely affect performance. As in all linear circuits, bypass capacitors must be used to decouple the amplifier.

Place a 0.1  $\mu F$  capacitor close to each supply pin. A 10  $\mu F$  tantalum capacitor can be used farther away from the part (see Figure 55) and, in most cases, it can be shared by other precision integrated circuits.

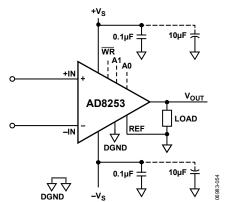
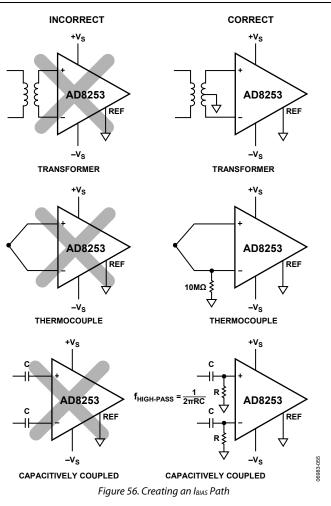


Figure 55. Supply Decoupling, REF, and Output Referred to Ground

#### **INPUT BIAS CURRENT RETURN PATH**

The AD8253 input bias current must have a return path to its local analog ground. When the source, such as a thermocouple, cannot provide a return current path, one should be created (see Figure 56).



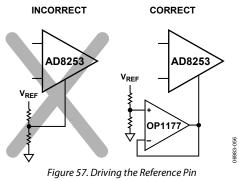
## INPUT PROTECTION

All terminals of the AD8253 are protected against ESD. An external resistor should be used in series with each of the inputs to limit current for voltages greater than 0.5 V beyond either supply rail. In such a case, the AD8253 safely handles a continuous 6 mA current at room temperature. For applications where the AD8253 encounters extreme overload voltages, external series resistors and low leakage diode clamps such as BAV199Ls, FJH1100s, or SP720s should be used.

#### **REFERENCE TERMINAL**

The reference terminal, REF, is at one end of a 10 k $\Omega$  resistor (see Figure 51). The instrumentation amplifier output is referenced to the voltage on the REF terminal; this is useful when the output signal needs to be offset to voltages other than its local analog ground. For example, a voltage source can be tied to the REF pin to level shift the output so that the AD8253 can interface with a single-supply ADC. The allowable reference voltage range is a function of the gain, common-mode input, and supply voltages. The REF pin should not exceed either +V<sub>s</sub> or -V<sub>s</sub> by more than 0.5 V.

For best performance, especially in cases where the output is not measured with respect to the REF terminal, source impedance to the REF terminal should be kept low because parasitic resistance can adversely affect CMRR and gain accuracy.



#### **COMMON-MODE INPUT VOLTAGE RANGE**

The 3-op-amp architecture of the AD8253 applies gain and then removes the common-mode voltage. Therefore, internal nodes in the AD8253 experience a combination of both the gained signal and the common-mode signal. This combined signal can be limited by the voltage supplies even when the individual input and output signals are not. Figure 28 and Figure 29 show the allowable common-mode input voltage ranges for various output voltages, supply voltages, and gains.

## LAYOUT

#### Grounding

In mixed-signal circuits, low level analog signals need to be isolated from the noisy digital environment. Designing with the AD8253 is no exception. Its supply voltages are referenced to an analog ground. Its digital circuit is referenced to a digital ground. Although it is convenient to tie both grounds to a single ground plane, the current traveling through the ground wires and PC board can cause an error. Therefore, use separate analog and digital ground planes. Only at one point, star ground, should analog and digital ground meet.

The output voltage of the AD8253 develops with respect to the potential on the reference terminal. Take care to tie REF to the appropriate local analog ground or to connect it to a voltage that is referenced to the local analog ground.

#### **Coupling Noise**

To prevent coupling noise onto the AD8253, follow these guidelines:

- Do not run digital lines under the device.
- Run the analog ground plane under the AD8253.
- Shield fast-switching signals with digital ground to avoid radiating noise to other sections of the board, and never run them near analog signal paths.
- Avoid crossover of digital and analog signals.
- Connect digital and analog ground at one point only (typically under the ADC).
- Power supply lines should use large traces to ensure a low impedance path. Decoupling is necessary; follow the guidelines listed in the Power Supply Regulation and Bypassing section.

#### **Common-Mode Rejection**

The AD8253 has high CMRR over frequency, giving it greater immunity to disturbances, such as line noise and its associated harmonics, in contrast to typical in amps whose CMRR falls off around 200 Hz. They often need common-mode filters at the inputs to compensate for this shortcoming. The AD8253 is able to reject CMRR over a greater frequency range, reducing the need for input common-mode filtering.

Careful board layout maximizes system performance. To maintain high CMRR over frequency, lay out the input traces symmetrically. Ensure that the traces maintain resistive and capacitive balance; this holds for additional PCB metal layers under the input pins and traces. Source resistance and capacitance should be placed as close to the inputs as possible. Should a trace cross the inputs (from another layer), it should be routed perpendicular to the input traces.

#### **RF INTERFERENCE**

RF rectification is often a problem when amplifiers are used in applications where there are strong RF signals. The disturbance can appear as a small dc offset voltage. High frequency signals can be filtered with a low-pass RC network placed at the input of the instrumentation amplifier, as shown in Figure 58. The filter limits the input signal bandwidth according to the following relationship:

$$FilterFreq_{DIFF} = \frac{1}{2 \pi R(2C_D + C_C)}$$
$$FilterFreq_{CM} = \frac{1}{2 \pi RC_C}$$

where  $C_D \ge 10 \text{ C}_{\text{C}}$ .

#### 

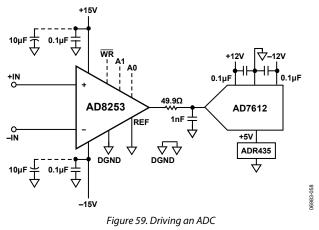
Values of R and C<sub>c</sub> should be chosen to minimize RFI. Mismatch between the  $R \times C_c$  at the positive input and the  $R \times C_c$  at negative input degrades the CMRR of the AD8253. By using a value of C<sub>D</sub> that is 10 times larger than the value of C<sub>c</sub>, the effect of the mismatch is reduced and performance is improved.

## DRIVING AN ANALOG-TO-DIGITAL CONVERTER

An instrumentation amplifier is often used in front of an analogto-digital converter to provide CMRR. Usually, instrumentation amplifiers require a buffer to drive an ADC. However, the low output noise, low distortion, and low settle time of the AD8253 make it an excellent ADC driver.

# In this example, a 1 nF capacitor and a 49.9 $\Omega$ resistor create an antialiasing filter for the AD7612. The 1 nF capacitor also serves to store and deliver necessary charge to the switched capacitor input of the ADC. The 49.9 $\Omega$ series resistor reduces the burden of the 1 nF load from the amplifier and isolates it from the kickback current injected from the switched capacitor input of the AD7612. Selecting too small a resistor improves the correlation between the voltage at the output of the AD8253 and the voltage at the input of the AD7612 but may destabilize the AD8253. A trade-off must be made between selecting a resistor small enough to maintain accuracy and large enough to maintain stability.

**Data Sheet** 



## APPLICATIONS INFORMATION DIFFERENTIAL OUTPUT

In certain applications, it is necessary to create a differential signal. High resolution analog-to-digital converters often require a differential input. In other cases, transmission over a long distance can require differential signals for better immunity to interference.

Figure 61 shows how to configure the AD8253 to output a differential signal. An op amp, the AD8675, is used in an inverting topology to create a differential voltage.  $V_{REF}$  sets the output midpoint according to the equation shown in the figure. Errors from the op amp are common to both outputs and are thus common mode. Likewise, errors from using mismatched resistors cause a common-mode dc offset error. Such errors are rejected in differential signal processing by differential input ADCs or instrumentation amplifiers.

When using this circuit to drive a differential ADC,  $V_{REF}$  can be set using a resistor divider from the ADC reference to make the output ratiometric with the ADC.

#### SETTING GAINS WITH A MICROCONTROLLER

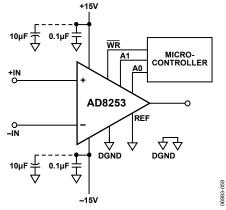
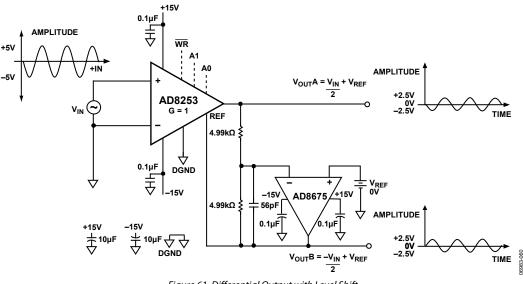
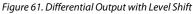


Figure 60. Programming Gain Using a Microcontroller





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## DATA ACQUISITION

The AD8253 makes an excellent instrumentation amplifier for use in data acquisition systems. Its wide bandwidth, low distortion, low settling time, and low noise enable it to condition signals in front of a variety of 16-bit ADCs.

Figure 63 shows the AD825x as part of a total data acquisition system. The quick slew rate of the AD8253 allows it to condition rapidly changing signals from the multiplexed inputs. An FPGA controls the AD7612, AD8253, and ADG1209. In addition, mechanical switches and jumpers allow users to pin strap the gains when in transparent gain mode.

This system achieved –116 dB of THD at 1 kHz and a signal-tonoise ratio of 91 dB during testing, as shown in Figure 62.

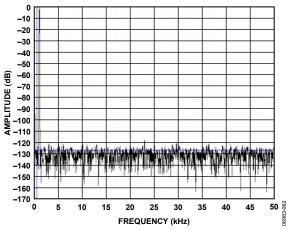


Figure 62. FFT of the AD825x in a Total Data Acquisition System Using the AD8253 1 kHz Signal

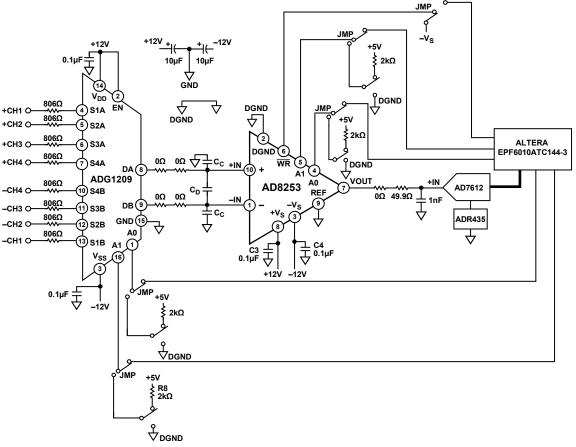


Figure 63. Schematic of ADG1209, AD8253, and AD7612 Used with the AD825x in a Total Data Acquisition System

# **OUTLINE DIMENSIONS**

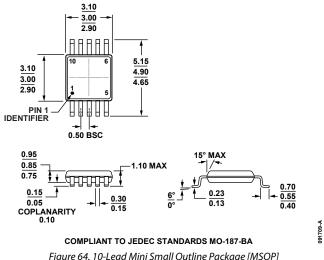


Figure 64. 10-Lead Mini Small Outline Package [MSOP] (RM-10) Dimensions shown in millimeters

#### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Package Description	Package Option	Branding
AD8253ARMZ	–40°C to +85°C	10-Lead MSOP	RM-10	YOK
AD8253ARMZ-RL	–40°C to +85°C	10-Lead MSOP	RM-10	YOK
AD8253ARMZ-R7	–40°C to +85°C	10-Lead MSOP	RM-10	YOK
AD8253-EVALZ		Evaluation Board		

 $^{1}$  Z = RoHS Compliant Part.

## NOTES

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